

AM26C31 Quadruple Differential Line Driver

1 Features

- Meets or exceeds the requirements of TIA/EIA-422-B and ITU recommendation V.11
- Low power, $I_{CC} = 100\mu A$ typical
- Operates from a single 5V supply
- High speed, $t_{PLH} = t_{PHL} = 7ns$ typical
- Low pulse distortion, $t_{sk(p)} = 0.5ns$ typical
- High output impedance in power-off conditions
- Improved replacement for AM26LS31 device
- Available in Q-temp automotive
 - High-reliability automotive applications
 - Configuration control and print support
 - Qualification to automotive standards
- On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

2 Applications

- Chemical and gas sensors
- Field transmitters: temperature sensors and pressure sensors
- Military: radars and sonars
- Motor control: brushless DC and brushed DC
- Military and avionics imaging
- Temperature sensors and controllers using modbus

3 Description

The AM26C31 device is a differential line driver with complementary outputs, designed to meet the requirements of TIA/EIA-422-B and ITU (formerly CCITT). The 3-state outputs have high-current capability for driving balanced lines, such as twisted-pair or parallel-wire transmission lines, and they provide the high-impedance state in the power-off condition. The enable functions are common to all four drivers and offer the choice of an active-high (G) or active-low ($\bar{G}$) enable input. BiCMOS circuitry reduces power consumption without sacrificing speed.

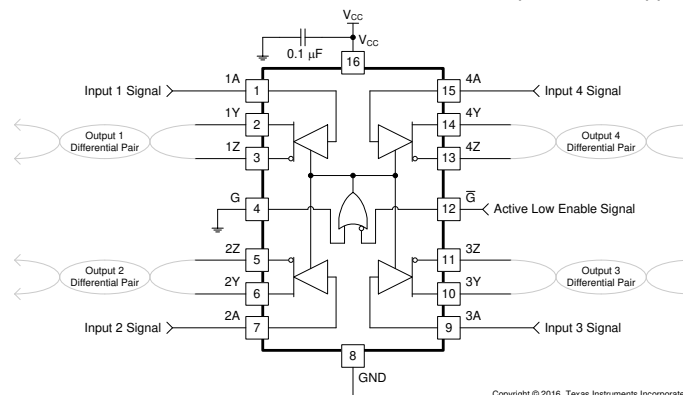
The AM26C31C device is characterized for operation from $0^{\circ}C$ to $70^{\circ}C$, the AM26C31I device is characterized for operation from $-40^{\circ}C$ to $+85^{\circ}C$, the AM26C31Q device is characterized for operation over the automotive temperature range of $-40^{\circ}C$ to $+125^{\circ}C$, and the AM26C31M device is characterized for operation over the full military temperature range of $-55^{\circ}C$ to $+125^{\circ}C$.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾
AM26C31	CDIP (J, 16)	19.56mm × 6.92mm
	PDIP (N, 16)	19.3mm × 6.35mm
	SO (NS, 16)	10.3mm × 5.3mm
	CFP (W, 16)	10.3mm × 6.73mm
	SOIC (D, 16)	9.9mm × 3.91mm
	SSOP (DB, 16)	6.2mm × 5.3mm
	TSSOP (PW, 16)	5.mm × 4.4mm
	LCCC (FK, 20)	8.89mm × 8.89mm

(1) For more information, see [Section 11](#).

(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Copyright © 2016, Texas Instruments Incorporated

Common Application Diagram



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

Table of Contents

1 Features	1	7 Detailed Description	11
2 Applications	1	7.1 Overview.....	11
3 Description	1	7.2 Functional Block Diagrams.....	11
4 Pin Configuration and Functions	3	7.3 Feature Description.....	12
5 Specifications	4	7.4 Device Functional Modes.....	12
5.1 Absolute Maximum Ratings.....	4	8 Application Information Disclaimer	13
5.2 ESD Ratings.....	4	8.1 Application Information.....	13
5.3 Recommended Operating Conditions.....	4	8.2 Typical Application.....	13
5.4 Thermal Information.....	5	8.3 Power Supply Recommendations.....	14
5.5 Electrical Characteristics: AM26C31C and AM26C31I.....	5	8.4 Layout.....	14
5.6 Electrical Characteristics: AM26C31Q and AM26C31M.....	6	9 Device and Documentation Support	16
5.7 Switching Characteristics: AM26C31C and AM26C31I.....	6	9.1 Receiving Notification of Documentation Updates....	16
5.8 Switching Characteristics: AM26C31Q and AM26C31M.....	7	9.2 Support Resources.....	16
5.9 Typical Characteristics.....	7	9.3 Trademarks.....	16
6 Parameter Measurement Information	8	9.4 Electrostatic Discharge Caution.....	16
		9.5 Glossary.....	16
		10 Revision History	16
		11 Mechanical, Packaging, and Orderable Information	17

4 Pin Configuration and Functions

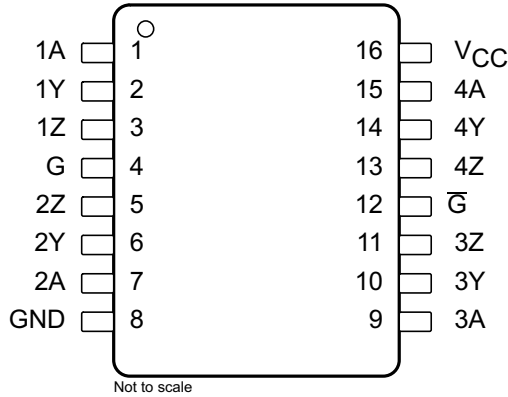


Figure 4-1. J (CDIP), W (CFP), D (SOIC), DB (SSOP), NS (SO), N (PDIP), or PW (TSSOP) Package 16-Pin (Top View)

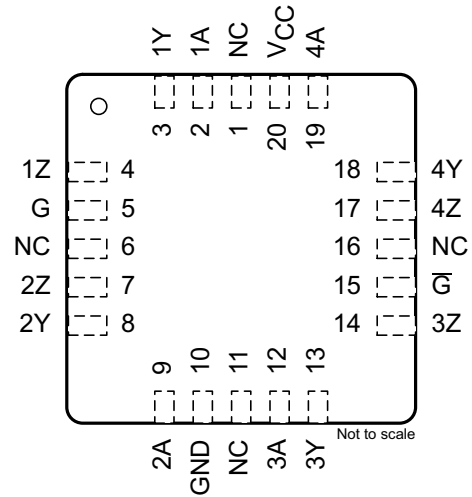


Figure 4-2. FK (LCCC) Package, 20-Pin (Top View)

Table 4-1. Pin Functions

NAME	PIN		TYPE	DESCRIPTION
	CDIP, CFP, SOIC, SSOP, SO, PDIP, TSSOP	LCCC		
1A	1	2	I	Driver 1 input
1Y	2	3	O	Driver 1 output
1Z	3	4	O	Driver 1 inverted output
2A	7	9	I	Driver 2 input
2Y	6	8	O	Driver 2 output
2Z	5	7	O	Driver 2 inverted output
3A	9	12	I	Driver 3 input
3Y	10	13	O	Driver 3 output
3Z	11	14	O	Driver 3 inverted output
4A	15	19	I	Driver 3 input
4Y	14	18	O	Driver 3 output
4Z	13	17	O	Driver 3 inverted output
G	4	5	I	Active high enable
Ḡ	12	15	I	Active low enable
GND	8	10	—	Ground pin
NC ⁽¹⁾	—	1, 6, 11, 16	—	No internal connection
V _{CC}	16	20	—	Power pin

(1) NC – No connection

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V _{CC}	Supply voltage ⁽²⁾	–0.5	7	V
V _I	Input voltage	–0.5	V _{CC} + 0.5	V
V _{ID}	Differential input voltage	–14	14	V
V _O	Output voltage	–0.5	7	V
I _{IK} I _{OK}	Input or output clamp current		±20	mA
I _O	Output current		±150	mA
	V _{CC} current		200	mA
	GND current	–200		mA
T _J	Operating virtual junction temperature		150	°C
T _{stg}	Storage temperature	–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential voltages, are with respect to the network ground terminal.

5.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		4.5	5	5.5	V
V _{ID}	Differential input voltage			±7		V
V _{IH}	High-level input voltage		2			V
V _{IL}	Low-level input voltage				0.8	V
I _{OH}	High-level output current				–20	mA
I _{OL}	Low-level output current				20	mA
T _A	Operating free-air temperature	AM26C31C		0	70	°C
		AM26C31I		–40	85	
		AM26C31Q		–40	125	
		AM26C31M		–55	125	

5.4 Thermal Information

THERMAL METRIC ⁽¹⁾		AM26C31								UNIT
		D (SOIC)	DB (SSOP)	PW (TSSOP)	NS (SO)	N (PDIP)	J (CDIP)	W (CFP)	FK (LCCC)	
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	
R _{θJA}	Junction-to-ambient thermal resistance ^{(2) (3)}	84.6	102.6	107.5	88.5	60.6	—	—	—	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	43.5	48.7	38.4	46.2	48.1	39.3 ⁽⁴⁾	58.9 ⁽⁴⁾	37.1 ⁽⁴⁾	°C/W
R _{θJB}	Junction-to-board thermal resistance	43.2	54.3	53.7	50.7	40.6	56.4 ⁽⁴⁾	109.3 ⁽⁴⁾	36.2 ⁽⁴⁾	°C/W
ψ _{JT}	Junction-to-top characterization parameter	10.4	11.8	3.2	13.5	27.5	—	—	—	°C/W
ψ _{JB}	Junction-to-board characterization parameter	42.8	53.5	53.1	50.3	40.3	—	—	—	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	n/a	n/a	12 ⁽⁴⁾	5.7 ⁽⁴⁾	4.3 ⁽⁴⁾	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.
- (2) Maximum power dissipation is a function of T_{J(max)}, R_{θJA}, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is P_D = (T_{J(max)} – T_A) / R_{θJA}. Operating at the absolute maximum T_J of 150°C can affect reliability.
- (3) The package thermal impedance is calculated in accordance with JESD 51-7.
- (4) Modelling assumption: MIL-STD-883 for R_{θJC(top)} and R_{θJC(bot)} JESD51 for R_{θJB}.

5.5 Electrical Characteristics: AM26C31C and AM26C31I

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	I _O = –20mA		2.4	3.4		V
V _{OL}	Low-level output voltage	I _O = 20mA			0.2	0.4	V
V _{OD}	Differential output voltage magnitude	R _L = 100Ω, see Figure 6-1		2	3.1		V
Δ V _{OD}	Change in magnitude of differential output voltage ⁽²⁾	R _L = 100Ω, see Figure 6-1				±0.4	V
V _{OC}	Common-mode output voltage	R _L = 100Ω, see Figure 6-1				3	V
Δ V _{OC}	Change in magnitude of common-mode output voltage ⁽²⁾	R _L = 100Ω, see Figure 6-1				±0.4	V
I _I	Input current	V _I = V _{CC} or GND				±1	μA
I _{O(off)}	Driver output current with power off	V _{CC} = 0	V _O = 6V			100	μA
			V _O = –0.25V			–100	
I _{OS}	Driver output short-circuit current	V _O = 0		–30		–150	mA
I _{OZ}	High-impedance off-state output current	V _O = 2.5V				20	μA
		V _O = 0.5V				–20	
I _{CC}	Quiescent supply current	I _O = 0	V _I = 0 or 5V			100	μA
			V _I = 2.4V or 0.5V ⁽³⁾		1.5	3	mA
C _i	Input capacitance				6		pF

- (1) All typical values are at V_{CC} = 5V and T_A = 25°C.
- (2) Δ|V_{OD}| and Δ|V_{OC}| are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.
- (3) This parameter is measured per input. All other inputs are at 0V or 5V.

5.6 Electrical Characteristics: AM26C31Q and AM26C31M

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	I _O = –20mA	2.2	3.4		V
V _{OL}	Low-level output voltage	I _O = 20mA		0.2	0.4	V
V _{OD}	Differential output voltage magnitude	R _L = 100Ω, see Figure 6-1	2	3.1		V
Δ V _{OD}	Change in magnitude of differential output voltage ⁽²⁾	R _L = 100Ω, see Figure 6-1			±0.4	V
V _{OC}	Common-mode output voltage	R _L = 100Ω, see Figure 6-1			3	V
Δ V _{OC}	Change in magnitude of common-mode output voltage ⁽²⁾	R _L = 100Ω, see Figure 6-1			±0.4	V
I _I	Input current	V _I = V _{CC} or GND			±1	μA
I _{O(off)}	Driver output current with power off	V _{CC} = 0			100	μA
		V _O = 6V V _O = –0.25V			–100	
I _{OS}	Driver output short-circuit current	V _O = 0			–170	mA
I _{OZ}	High-impedance off-state output current	V _O = 2.5V V _O = 0.5V			20 –20	μA
I _{CC}	Quiescent supply current	I _O = 0			100	μA
		V _I = 0 or 5V V _I = 2.4V or 0.5V ⁽³⁾			3.2	mA
C _i	Input capacitance			6		pF

(1) All typical values are at V_{CC} = 5V and T_A = 25°C.

(2) Δ|V_{OD}| and Δ|V_{OC}| are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.

(3) This parameter is measured per input. All other inputs are at 0V or 5V.

5.7 Switching Characteristics: AM26C31C and AM26C31I

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high-level output	S1 is open, see Figure 6-2	3	7	12	ns
t _{PHL}	Propagation delay time, high-to-low-level output		3	7	12	
t _{sk(p)}	Pulse skew time (t _{PLH} – t _{PHL})	S1 is open, see Figure 6-2		0.5	4	ns
t _{r(OD)} , t _{f(OD)}	Differential output rise and fall times	S1 is open, see Figure 6-3		5	10	ns
t _{PZH}	Output enable time to high level	S1 is closed, see Figure 6-4		10	19	ns
t _{PZL}	Output enable time to low level			10	19	
t _{PHZ}	Output disable time from high level	S1 is closed, see Figure 6-4		7	16	ns
t _{PLZ}	Output disable time from low level			7	16	
C _{pd}	Power dissipation capacitance (each driver) ⁽²⁾	S1 is open, see Figure 6-2		170		pF

(1) All typical values are at V_{CC} = 5V and T_A = 25°C.

(2) C_{pd} is used to estimate the switching losses according to P_D = C_{pd} × V_{CC}² × f, where f is the switching frequency.

5.8 Switching Characteristics: AM26C31Q and AM26C31M

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output	S1 is open, see Figure 6-2		7	12	ns
t_{PHL}	Propagation delay time, high-to-low-level output			6.5	12	
$t_{sk(p)}$	Pulse skew time ($ t_{PLH} - t_{PHL} $)	S1 is open, see Figure 6-2		0.5	4	ns
$t_{r(OD)}, t_{f(OD)}$	Differential output rise and fall times	S1 is open, see Figure 6-3		5	12	ns
t_{PZH}	Output enable time to high level	S1 is closed, see Figure 6-4		10	19	ns
t_{PZL}	Output enable time to low level			10	19	
t_{PHZ}	Output disable time from high level	S1 is closed, see Figure 6-4		7	16	ns
t_{PLZ}	Output disable time from low level			7	16	
C_{pd}	Power dissipation capacitance (each driver) ⁽²⁾	S1 is open, see Figure 6-2		100		pF

(1) All typical values are at $V_{CC} = 5V$ and $T_A = 25^\circ C$.

(2) C_{pd} is used to estimate the switching losses according to $P_D = C_{pd} \times V_{CC}^2 \times f$, where f is the switching frequency.

5.9 Typical Characteristics

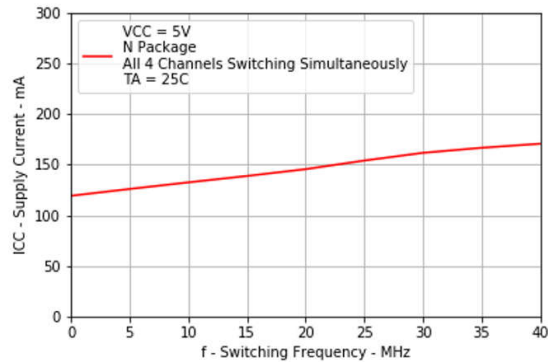


Figure 5-1. Supply Current vs Switching Frequency

6 Parameter Measurement Information

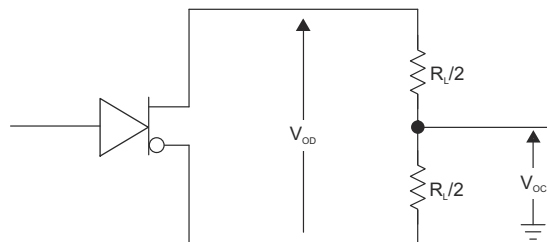
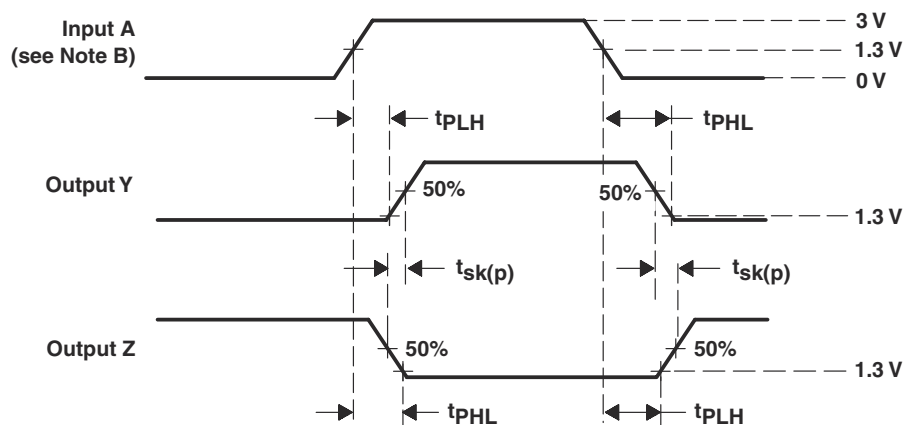
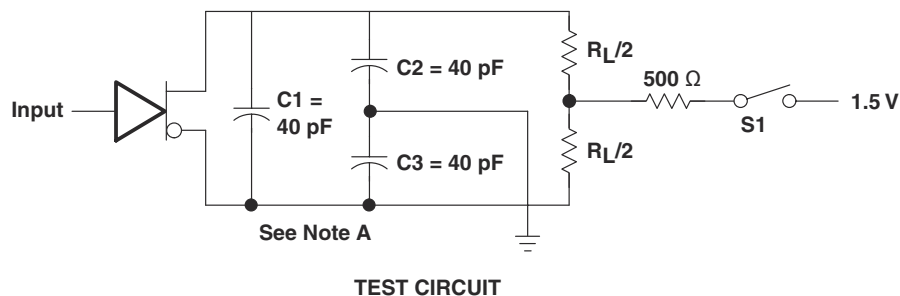
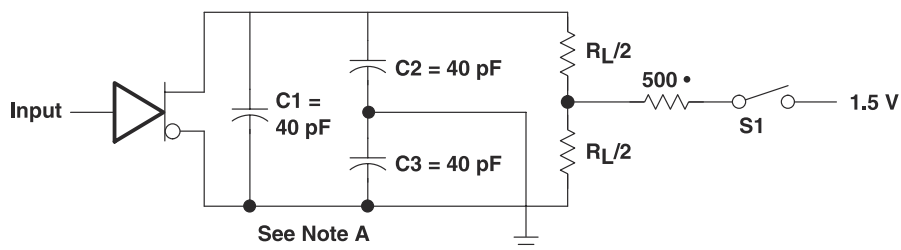


Figure 6-1. Differential and Common-Mode Output Voltages

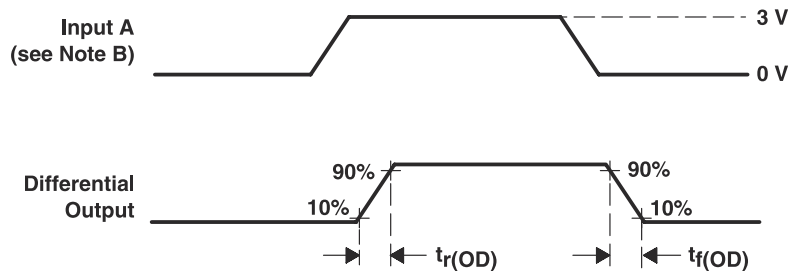


- A. C1, C2, and C3 include probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{ MHz}$, duty cycle $\leq 50\%$, and $t_r, t_f \leq 6\text{ ns}$.

Figure 6-2. Propagation Delay Time and Skew Waveforms and Test Circuit



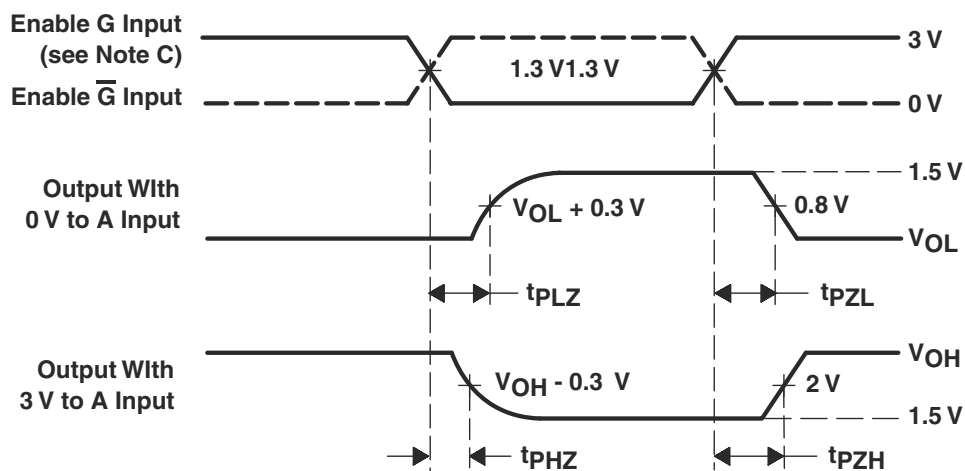
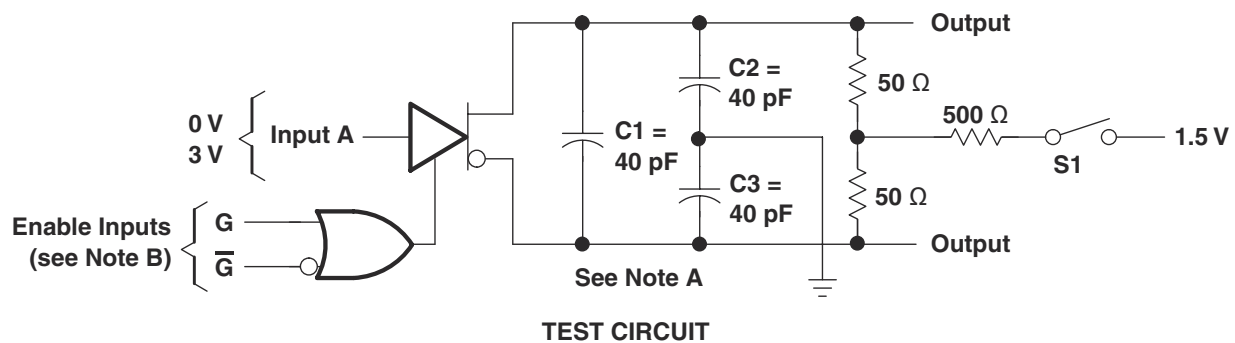
TEST CIRCUIT



VOLTAGE WAVEFORMS

- A. C1, C2, and C3 include probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{MHz}$, duty cycle $\leq 50\%$, and $t_r, t_f \leq 6\text{ns}$.

Figure 6-3. Differential-Output Rise and Fall-Time Waveforms and Test Circuit



- A. C1, C2, and C3 include probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR $\leq$ 1MHz, duty cycle $\leq$ 50%, and t_r , $t_f \leq$ 6ns.
- C. Each enable is tested separately.

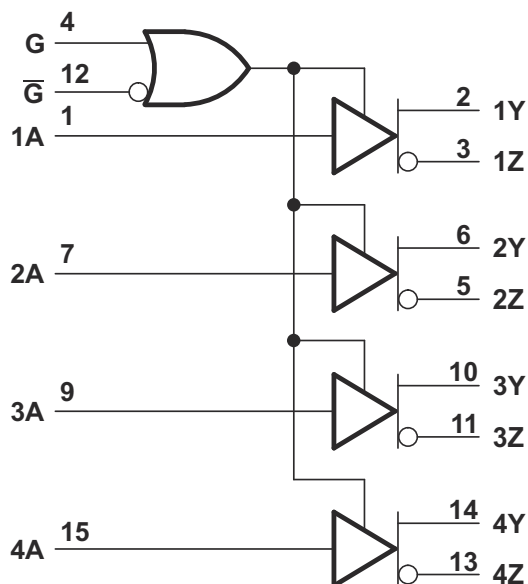
Figure 6-4. Output Enable and Disable Time Waveforms and Test Circuit

7 Detailed Description

7.1 Overview

The AM26C31 is a quadruple differential line driver with complementary outputs. The device is designed to meet the requirements of TIA/EIA-422-B and ITU (formerly CCITT), and it is generally used to communicate over relatively long wires in noisy environments.

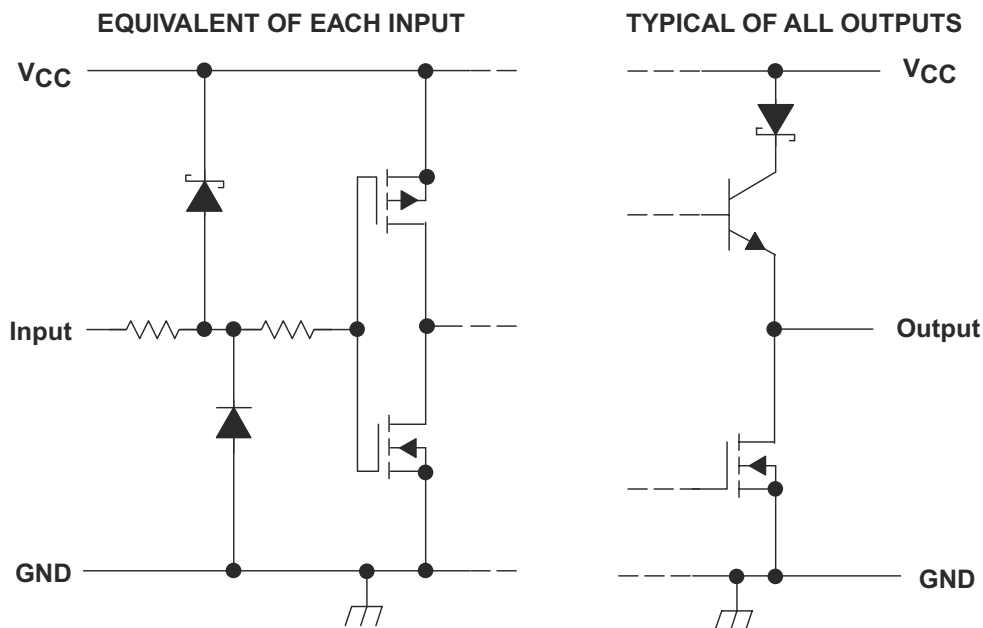
7.2 Functional Block Diagrams



Copyright © 2016, Texas Instruments Incorporated

Pin numbers shown are for the D, DB, J, N, NS, PW, and W packages.

Figure 7-1. Logic Diagram (Positive Logic)



Copyright © 2016, Texas Instruments Incorporated

Figure 7-2. Schematics of Inputs and Outputs

7.3 Feature Description

7.3.1 Active-High and Active-Low

The device can be configured using the G and $\bar{G}$ logic inputs to select transmitter output. A logic high on the G pin or a logic low on the $\bar{G}$ pin enables the device to operate. These pins are simply a way to configure the logic to match that of the receiving or transmitting controller or microprocessor.

7.3.2 Operates From a Single 5V Supply

Both the logic and transmitters operate from a single 5V rail, making designs much more simple. The line drivers and receivers can operate off the same rail as the host controller or a similar low voltage supply, thus simplifying power structure.

7.4 Device Functional Modes

Table 7-1 lists the functional modes of the AM26C31.

Table 7-1. Function Table (Each Driver)⁽¹⁾

INPUT A	ENABLES		OUTPUTS	
	G	$\bar{G}$	Y	Z
H	H	X	H	L
L	H	X	L	H
H	X	L	H	L
L	X	L	L	H
X	L	H	Z	Z

- (1) H = High level,
L = Low level,
X = Irrelevant,
Z = High impedance (off)

8 Application Information Disclaimer

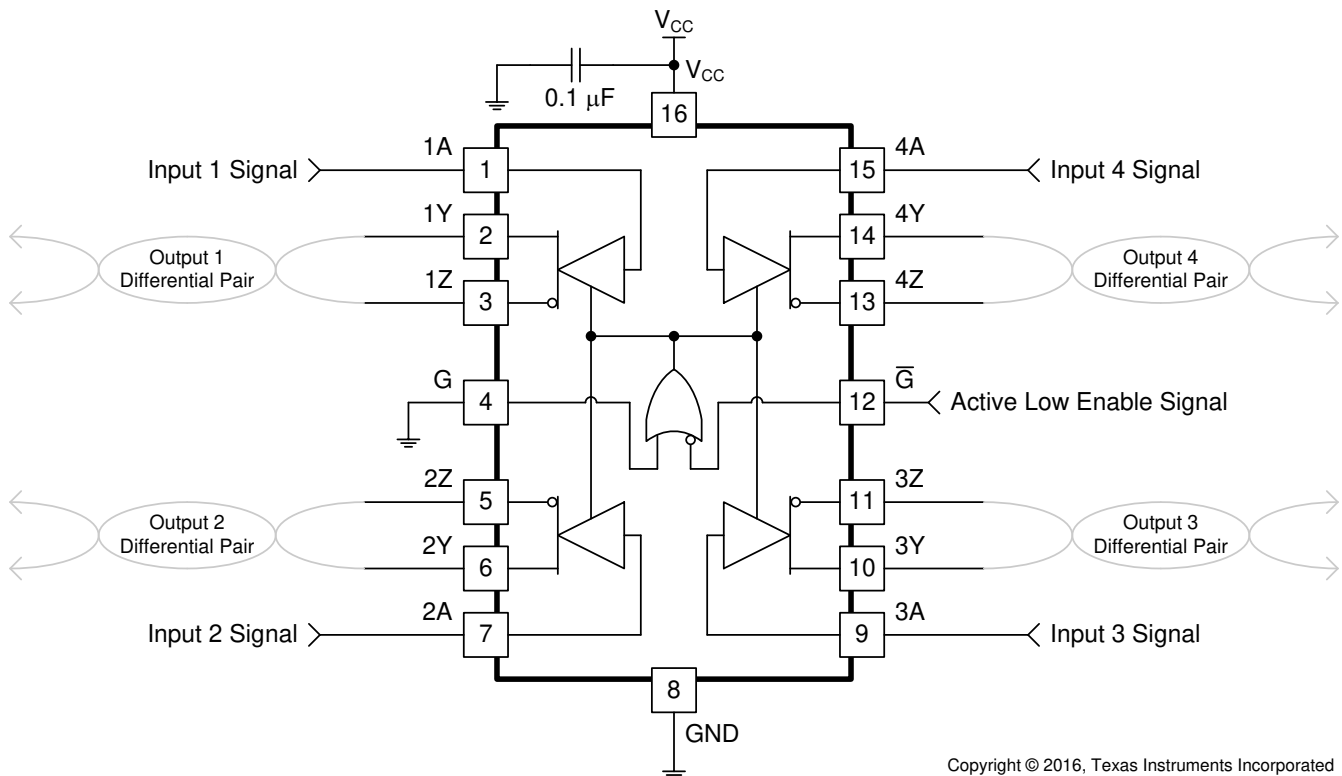
Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

When designing a system that uses drivers, receivers, and transceivers that comply with RS-422, proper cable termination is essential for highly reliable applications with reduced reflections in the transmission line. Because RS-422 allows only one driver on the bus, if termination is used, it is placed only at the end of the cable near the last receiver. Factors to consider when determining the type of termination usually are performance requirements of the application and the ever-present factor, cost. The different types of termination techniques discussed are unterminated lines, parallel termination, AC termination, and multipoint termination. For laboratory experiments, 100 feet of 100 Ω , 24-AWG, twisted-pair cable (Bertek) was used. A single driver and receiver, TI AM26C31C and AM26C32C, respectively, were tested at room temperature with a 5V supply voltage. To show voltage waveforms related to transmission-line reflections, the first plot shows output waveforms from the driver at the start of the cable (A/B); the second plot shows input waveforms to the receiver at the far end of the cable (Y).

8.2 Typical Application



Copyright © 2016, Texas Instruments Incorporated

Figure 8-1. Differential Terminated Configuration With All Channels and Active Low Enable Used

8.2.1 Design Requirements

Resistor and capacitor (if used) termination values are shown for each laboratory experiment, but vary from system to system. For example, the termination resistor, R_T , must be within 20% of the characteristic impedance, Z_0 , of the cable and can vary from about 80 Ω to 120 Ω .

8.2.2 Detailed Design Procedure

Ensure values in [Absolute Maximum Ratings](#) are not exceeded.

Supply voltage, V_{IH} , and V_{IL} must comply with [Recommended Operating Conditions](#).

8.2.3 Application Curve

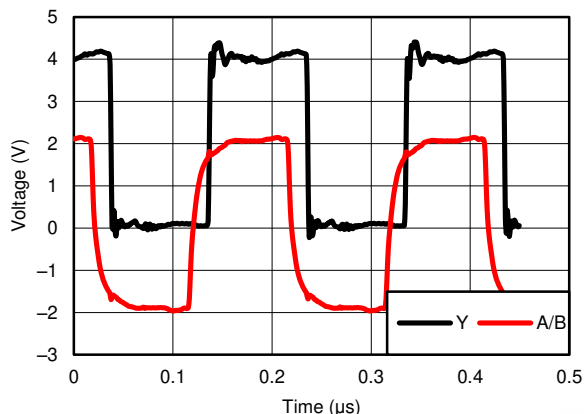


Figure 8-2. Differential 120Ω Terminated Output Waveforms (Cat 5E Cable)

8.3 Power Supply Recommendations

Place 0.1μF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high impedance power supplies.

8.4 Layout

8.4.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole, as well as the operational amplifier. Bypass capacitors are used to reduce the coupled noise by providing low impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1-μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If it is not possible to keep them separate, it is much better to cross the sensitive trace perpendicular as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. Keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

8.4.2 Layout Example

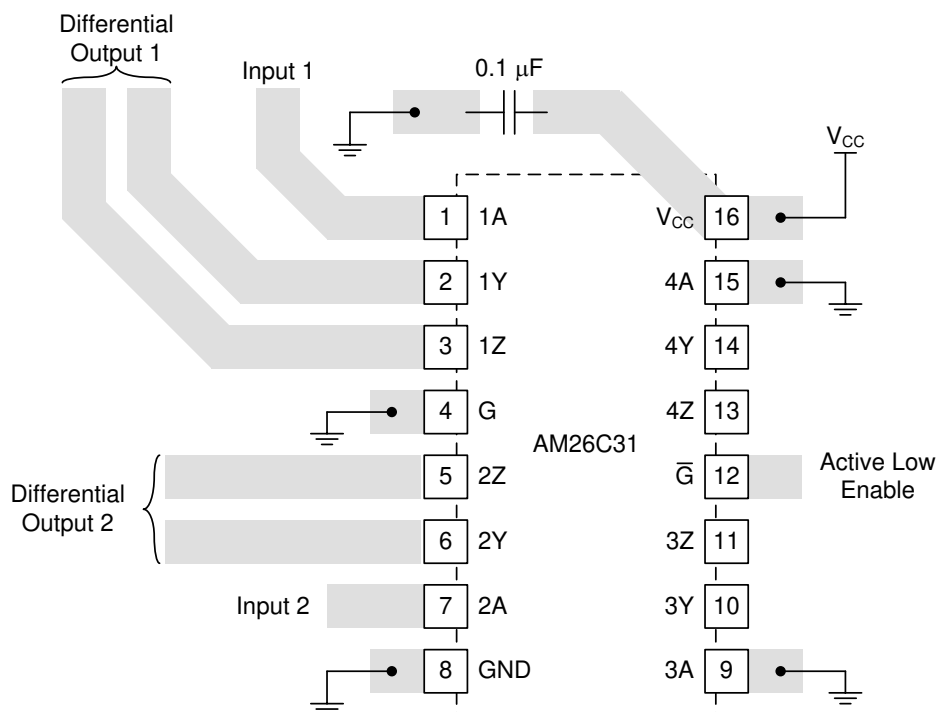


Figure 8-3. Trace Layout on PCB and Recommendations

9 Device and Documentation Support

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

9.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision O (June 2016) to Revision P (March 2024)	Page
• Changed the Device Information table to the <i>Package Information</i> table.....	1
• Changed <i>Thermal Information</i> table.....	5
• Changed Figure 5-1	7
• Changed Figure 6-1	8

Changes from Revision N (October 2011) to Revision O (February 2014)	Page
• Updated the <i>Features</i> section and added the <i>Applications</i> section, the <i>Device Information</i> table, <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section.....	1
• Deleted <i>Ordering Information</i> table, see POA at the end of the data sheet.....	1
• Changed <i>Thermal Information</i> table.....	5

Changes from Revision M (June 2008) to Revision N (October 2011)	Page
• Changed units to mA from μ A to fix units typo.....	4

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-9163901M2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9163901M2A AM26C31M
5962-9163901M2A.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9163901M2A AM26C31M
5962-9163901MEA	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901ME A AM26C31M
5962-9163901MEA.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901ME A AM26C31M
5962-9163901MFA	Active	Production	CFP (W) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901MF A AM26C31M
5962-9163901MFA.A	Active	Production	CFP (W) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901MF A AM26C31M
5962-9163901Q2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9163901Q2A AM26C31 MFKB
5962-9163901QEA	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QE A AM26C31MJB
5962-9163901QFA	Active	Production	CFP (W) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QF A AM26C31MWB
AM26C31CD	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	0 to 70	AM26C31C
AM26C31CDBR	Obsolete	Production	SSOP (DB) 16	-	-	Call TI	Call TI	0 to 70	26C31
AM26C31CDR	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	0 to 70	AM26C31C
AM26C31CN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	AM26C31CN
AM26C31CN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	AM26C31CN
AM26C31CNSR	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26C31

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
AM26C31CNSR.A	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	26C31
AM26C31ID	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 85	AM26C31I
AM26C31IDBR	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26C31I
AM26C31IDBR.A	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	26C31I
AM26C31IDBRE4	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	26C31I
AM26C31IDR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AM26C31I
AM26C31IDR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AM26C31I
AM26C31IDRG4	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 85	AM26C31I
AM26C31IN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 125	AM26C31IN
AM26C31IN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	AM26C31IN
AM26C31INE4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	AM26C31IN
AM26C31INSR	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26C31I
AM26C31INSR.A	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	26C31I
AM26C31IPW	Obsolete	Production	TSSOP (PW) 16	-	-	Call TI	Call TI	-40 to 85	26C31I
AM26C31IPWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	26C31I
AM26C31IPWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	26C31I
AM26C31IPWRG4	Obsolete	Production	TSSOP (PW) 16	-	-	Call TI	Call TI	-40 to 85	26C31I
AM26C31MFKB	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901Q2A AM26C31 MFKB
AM26C31MFKB.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901Q2A AM26C31 MFKB
AM26C31MJB	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QE A AM26C31MJB
AM26C31MJB.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QE A AM26C31MJB
AM26C31MWB	Active	Production	CFP (W) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QF A AM26C31MWB

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
AM26C31MWB.A	Active	Production	CFP (W) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9163901QF A AM26C31MWB
AM26C31QD	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 125	AM26C31Q
AM26C31QDG4	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 125	26C31Q
AM26C31QDR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AM26C31Q
AM26C31QDR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AM26C31Q
AM26C31QDRG4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26C31Q
AM26C31QDRG4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26C31Q

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF AM26C31, AM26C31M :

- Catalog : [AM26C31](#)
- Enhanced Product : [AM26C31-EP](#), [AM26C31-EP](#)
- Military : [AM26C31M](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Enhanced Product - Supports Defense, Aerospace and Medical Applications
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
AM26C31CNSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
AM26C31IDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
AM26C31IDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
AM26C31IDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
AM26C31INSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
AM26C31IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
AM26C31IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
AM26C31QDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
AM26C31QDRG4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

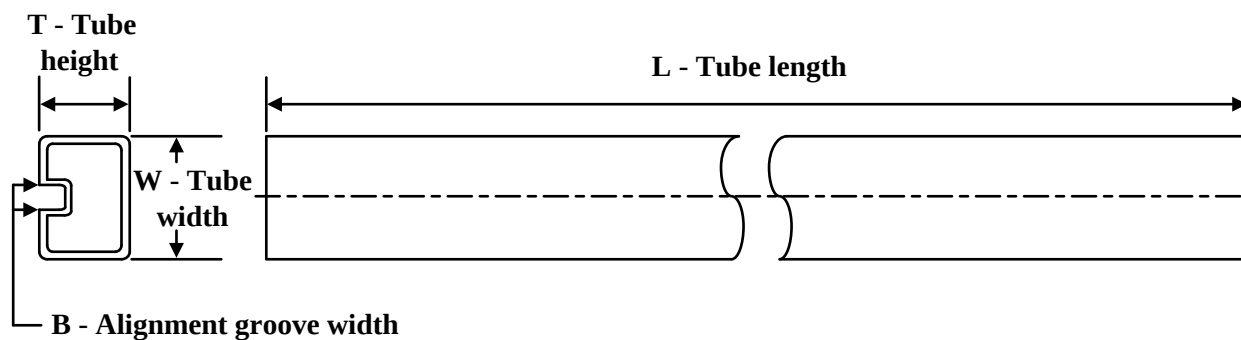
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
AM26C31CNSR	SOP	NS	16	2000	353.0	353.0	32.0
AM26C31IDBR	SSOP	DB	16	2000	353.0	353.0	32.0
AM26C31IDR	SOIC	D	16	2500	353.0	353.0	32.0
AM26C31IDR	SOIC	D	16	2500	340.5	336.1	32.0
AM26C31INSR	SOP	NS	16	2000	353.0	353.0	32.0
AM26C31IPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
AM26C31IPWR	TSSOP	PW	16	2000	353.0	353.0	32.0
AM26C31QDR	SOIC	D	16	2500	353.0	353.0	32.0
AM26C31QDRG4	SOIC	D	16	2500	353.0	353.0	32.0

TUBE

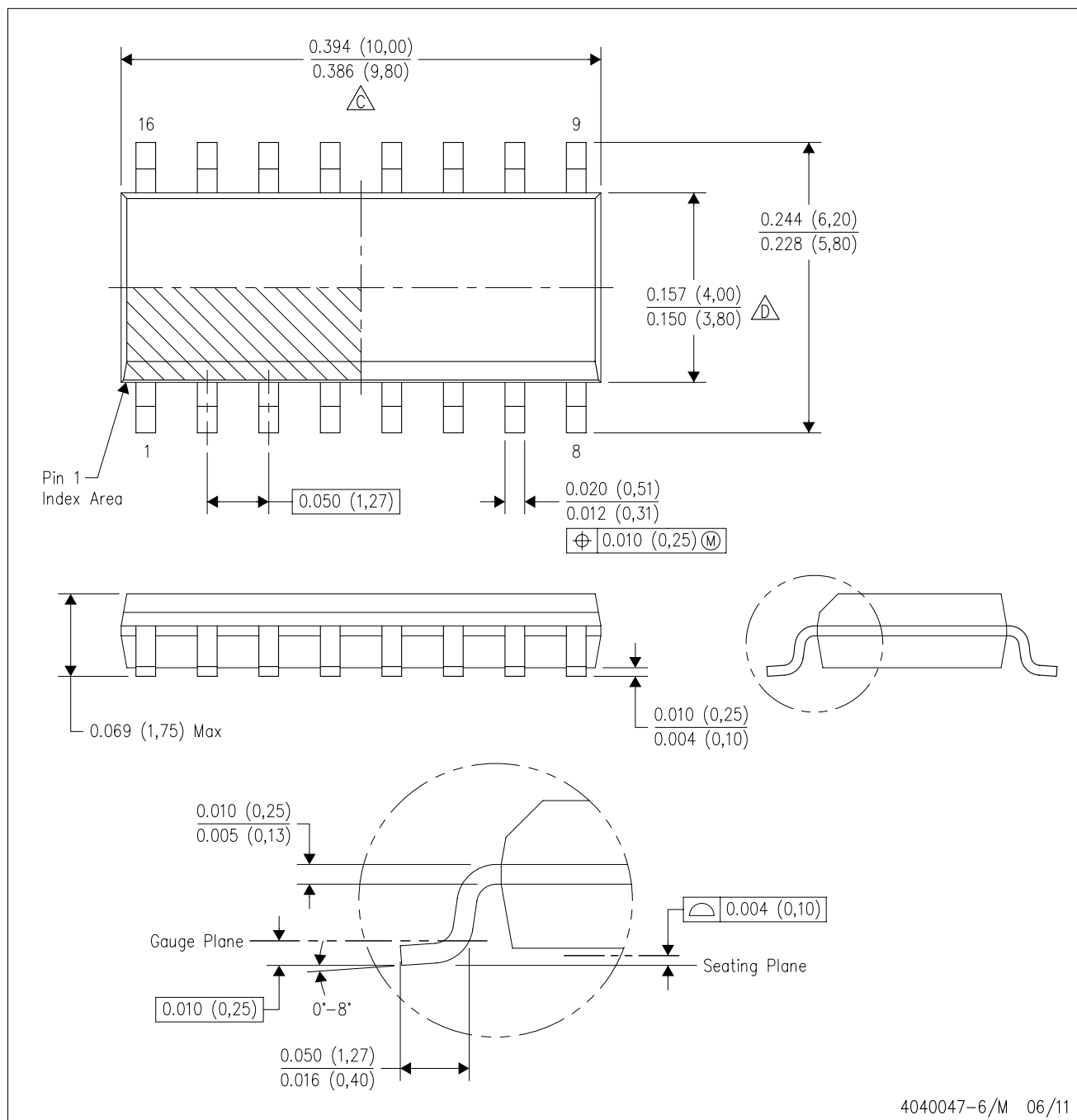


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
5962-9163901M2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9163901M2A.A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9163901MFA	W	CFP	16	25	506.98	26.16	6220	NA
5962-9163901MFA.A	W	CFP	16	25	506.98	26.16	6220	NA
5962-9163901Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9163901QFA	W	CFP	16	25	506.98	26.16	6220	NA
AM26C31CN	N	PDIP	16	25	506	13.97	11230	4.32
AM26C31CN.A	N	PDIP	16	25	506	13.97	11230	4.32
AM26C31IN	N	PDIP	16	25	506	13.97	11230	4.32
AM26C31IN.A	N	PDIP	16	25	506	13.97	11230	4.32
AM26C31INE4	N	PDIP	16	25	506	13.97	11230	4.32
AM26C31MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
AM26C31MFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA
AM26C31MWB	W	CFP	16	25	506.98	26.16	6220	NA
AM26C31MWB.A	W	CFP	16	25	506.98	26.16	6220	NA

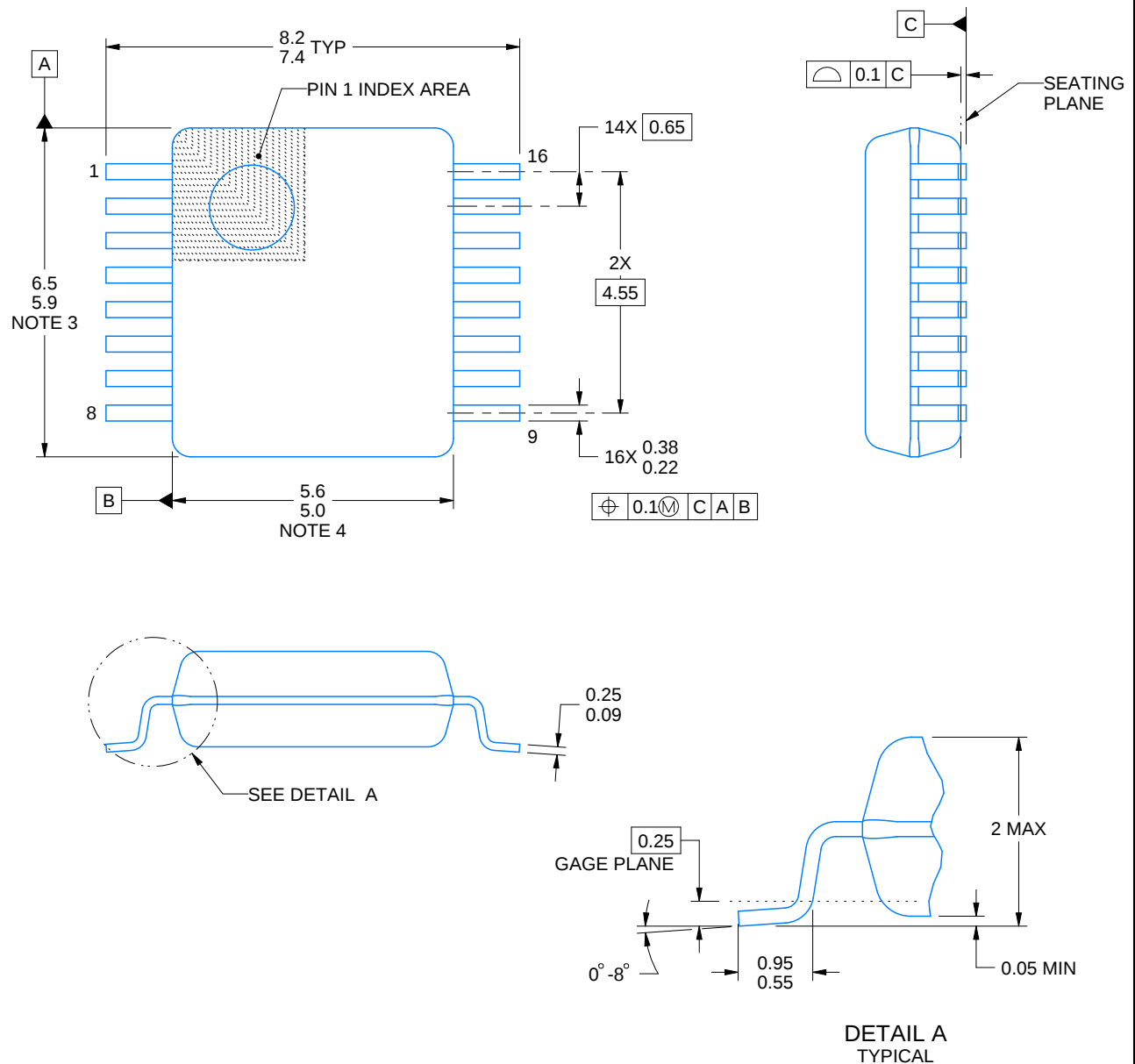
D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4220763/A 05/2022

NOTES:

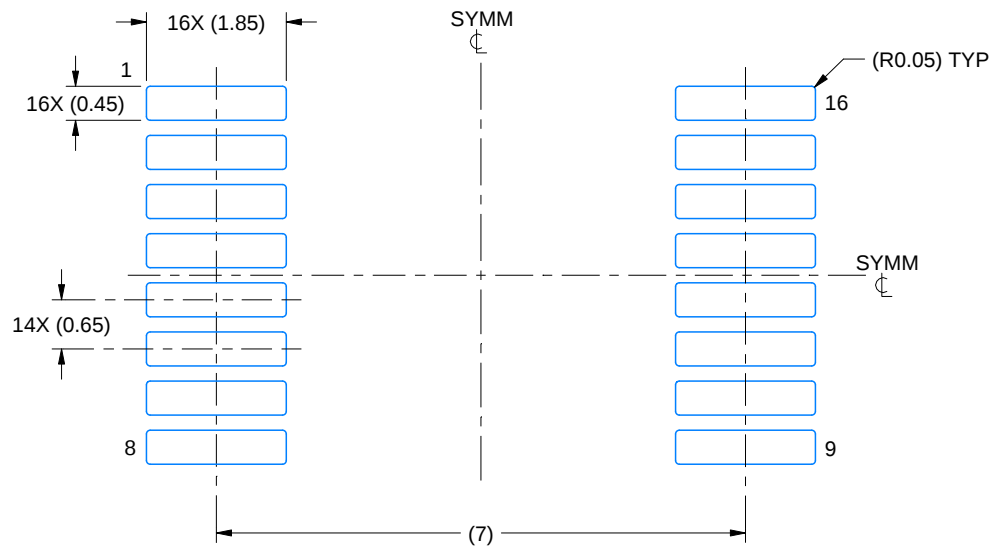
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-150.

EXAMPLE BOARD LAYOUT

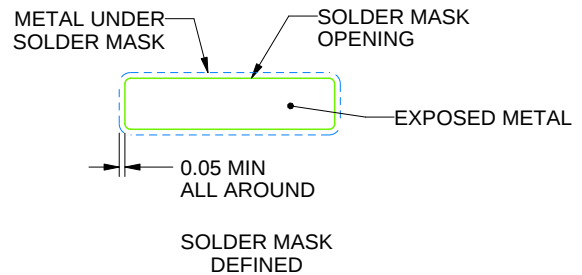
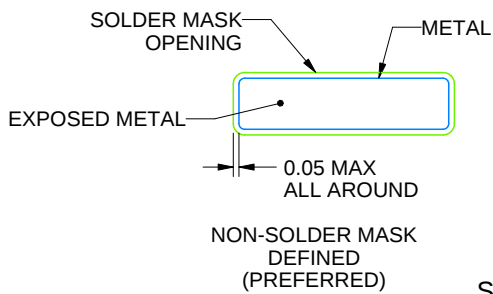
DB0016A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220763/A 05/2022

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

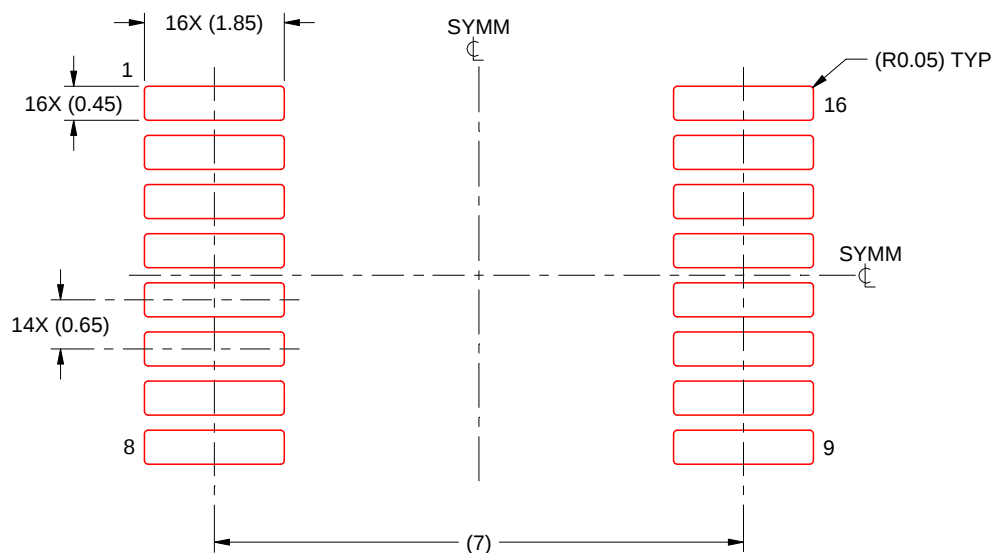
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DB0016A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

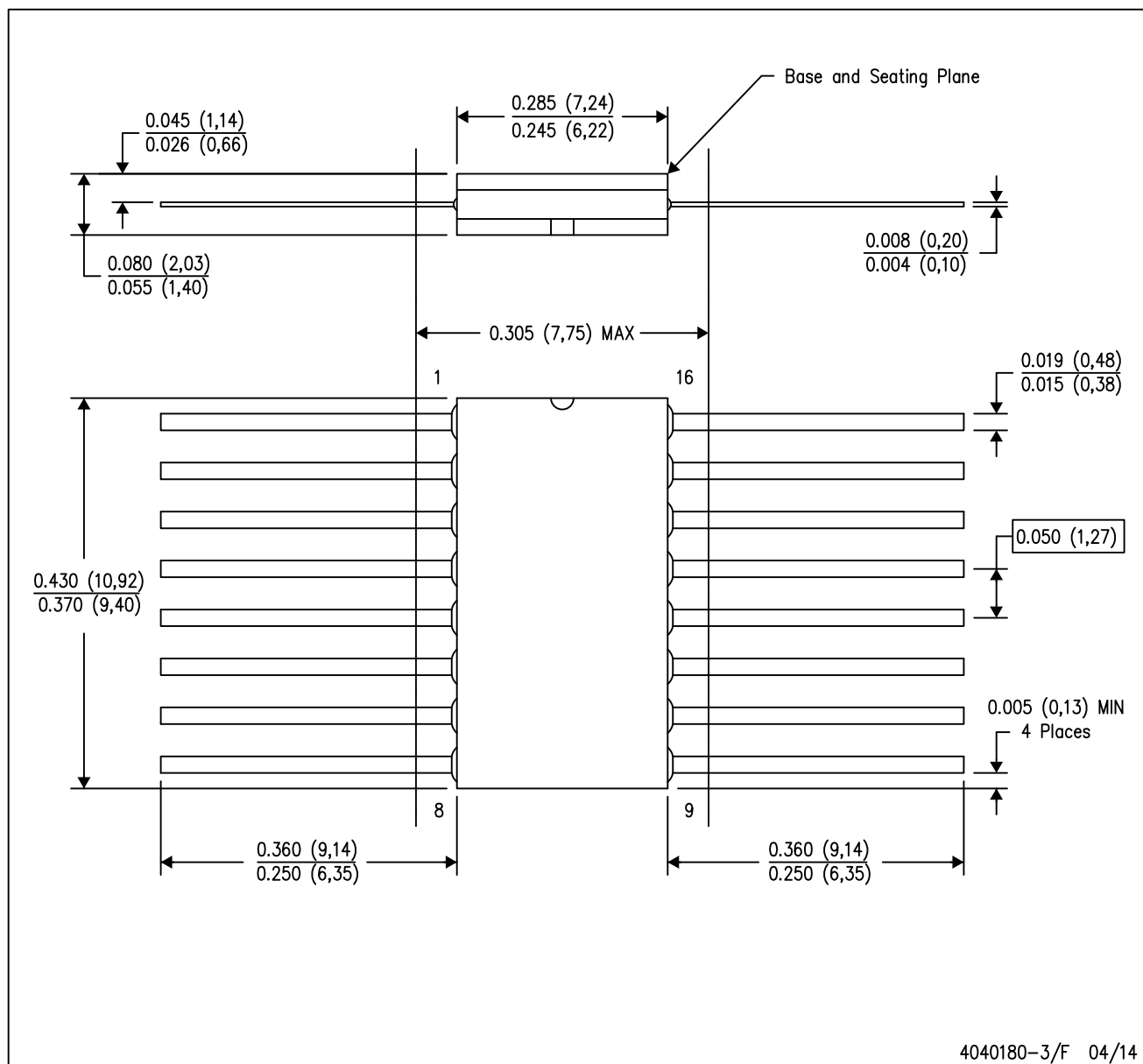
4220763/A 05/2022

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

W (R-GDFP-F16)

CERAMIC DUAL FLATPACK



- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - This package can be hermetically sealed with a ceramic lid using glass frit.
 - Index point is provided on cap for terminal identification only.
 - Falls within MIL STD 1835 GDFP2-F16

GENERIC PACKAGE VIEW

FK 20

LCCC - 2.03 mm max height

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

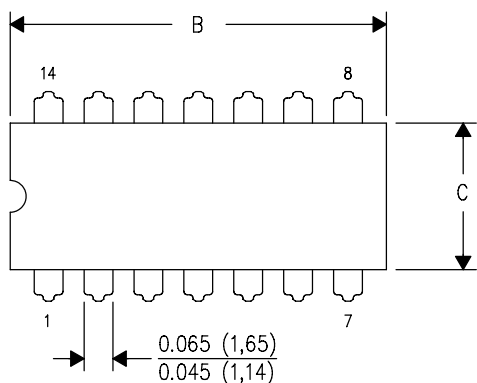


4229370VA\

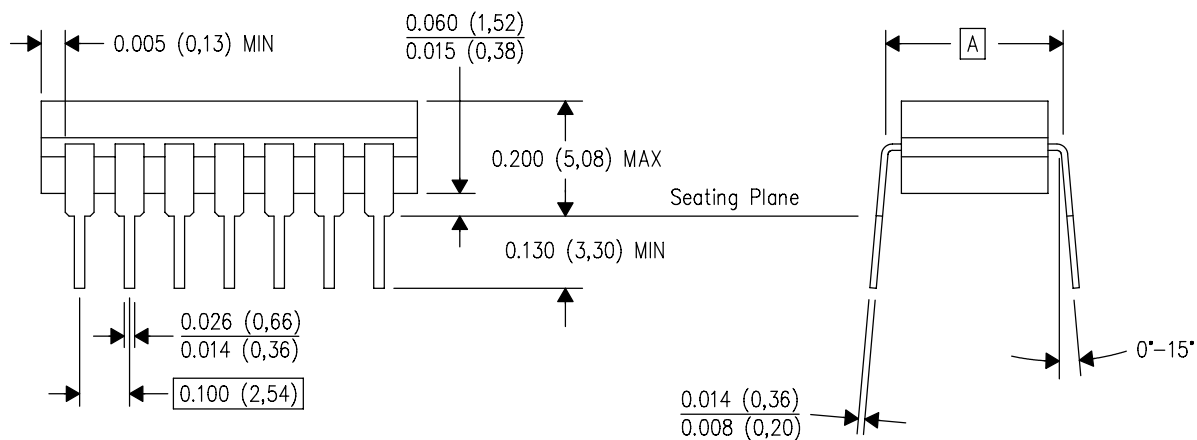
J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE

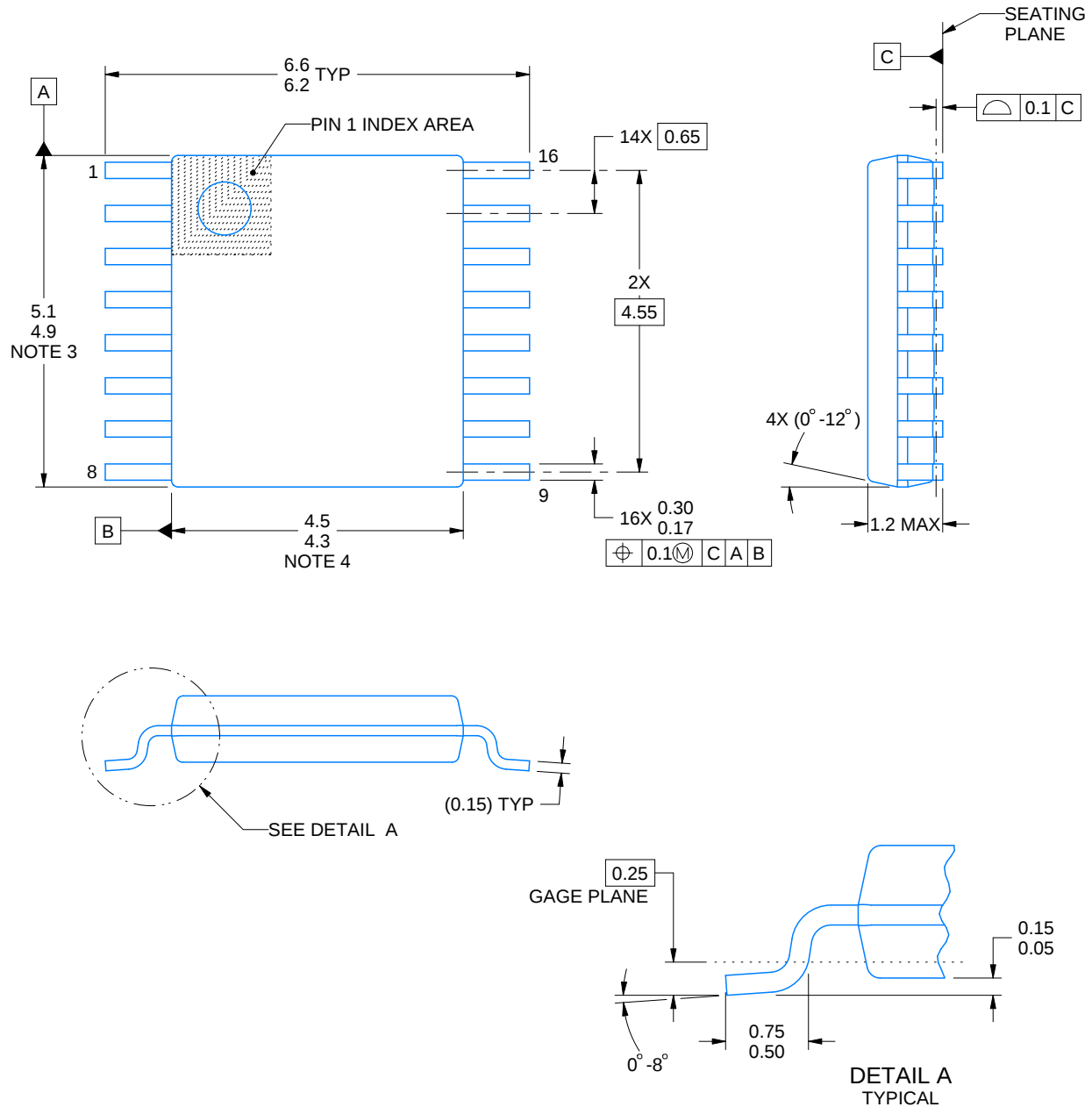
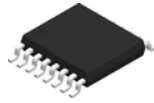


PINS ** DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.



4220204/B 12/2023

NOTES:

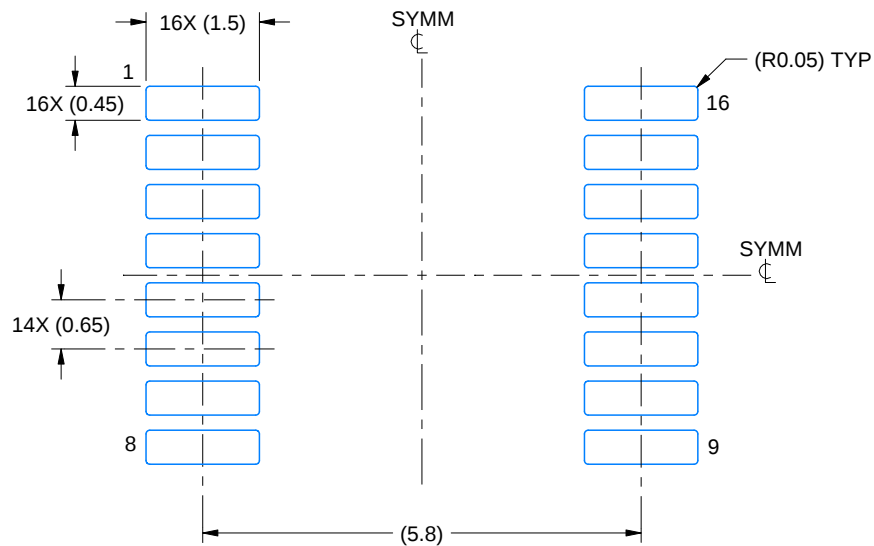
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

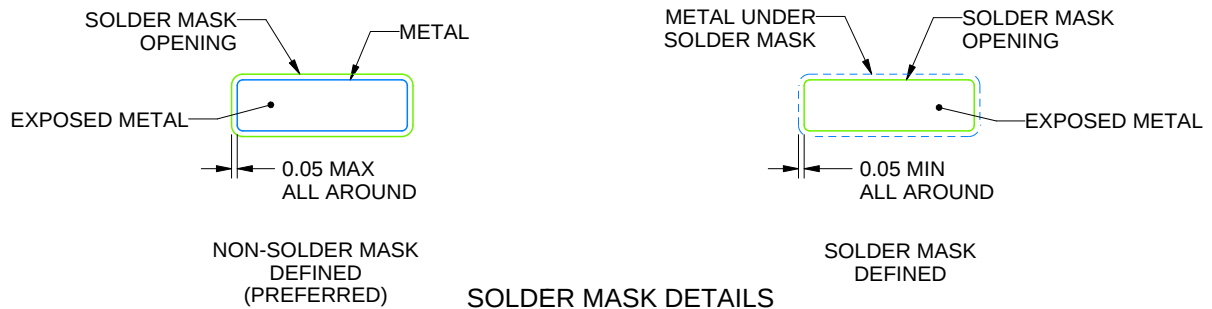
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

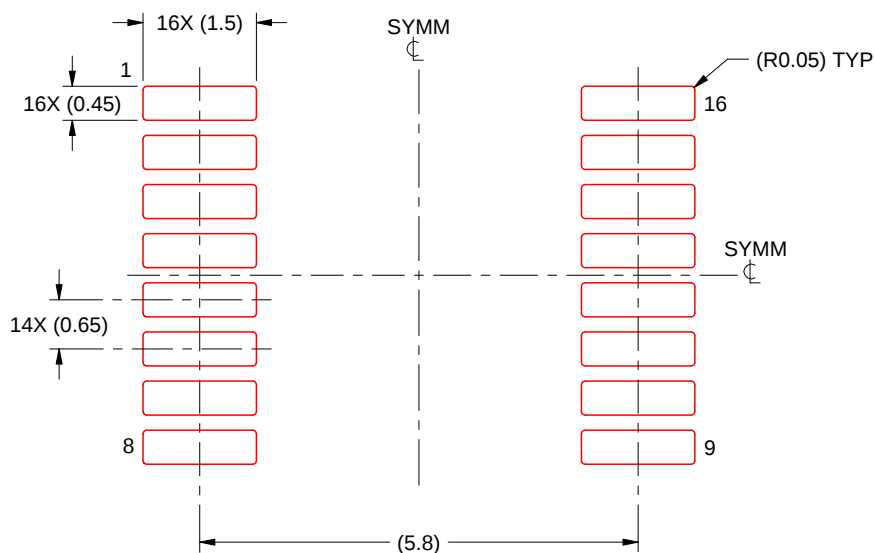
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

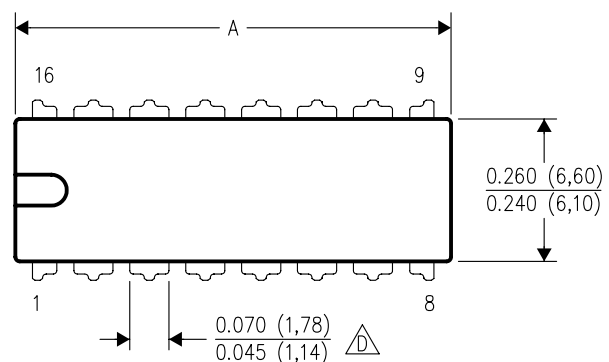
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

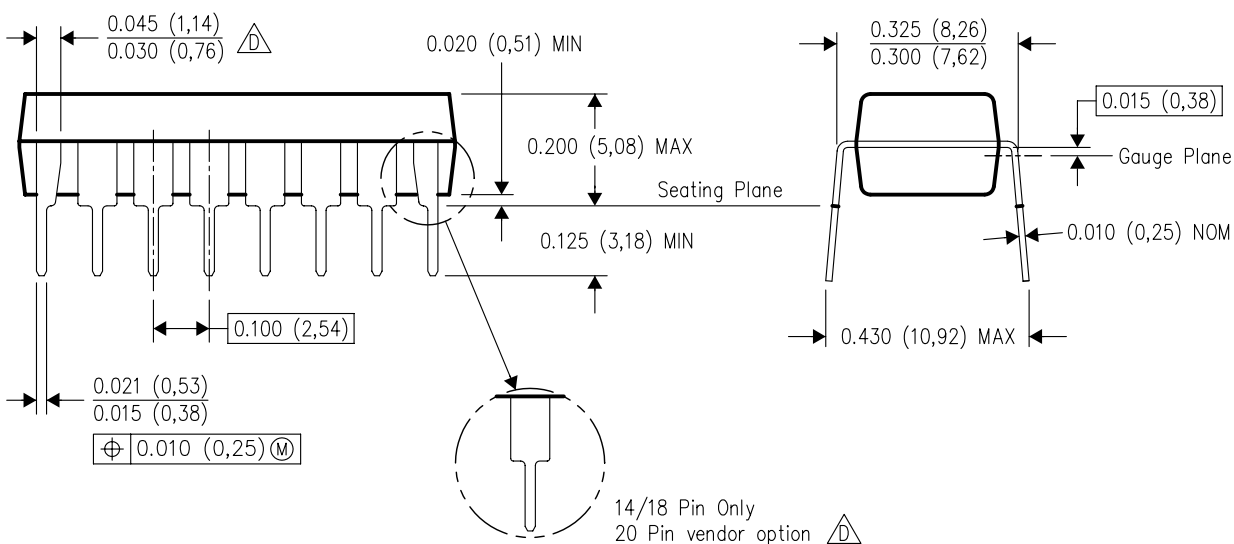
N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE

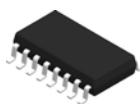


PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 -  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 -  The 20 pin end lead shoulder width is a vendor option, either half or full width.

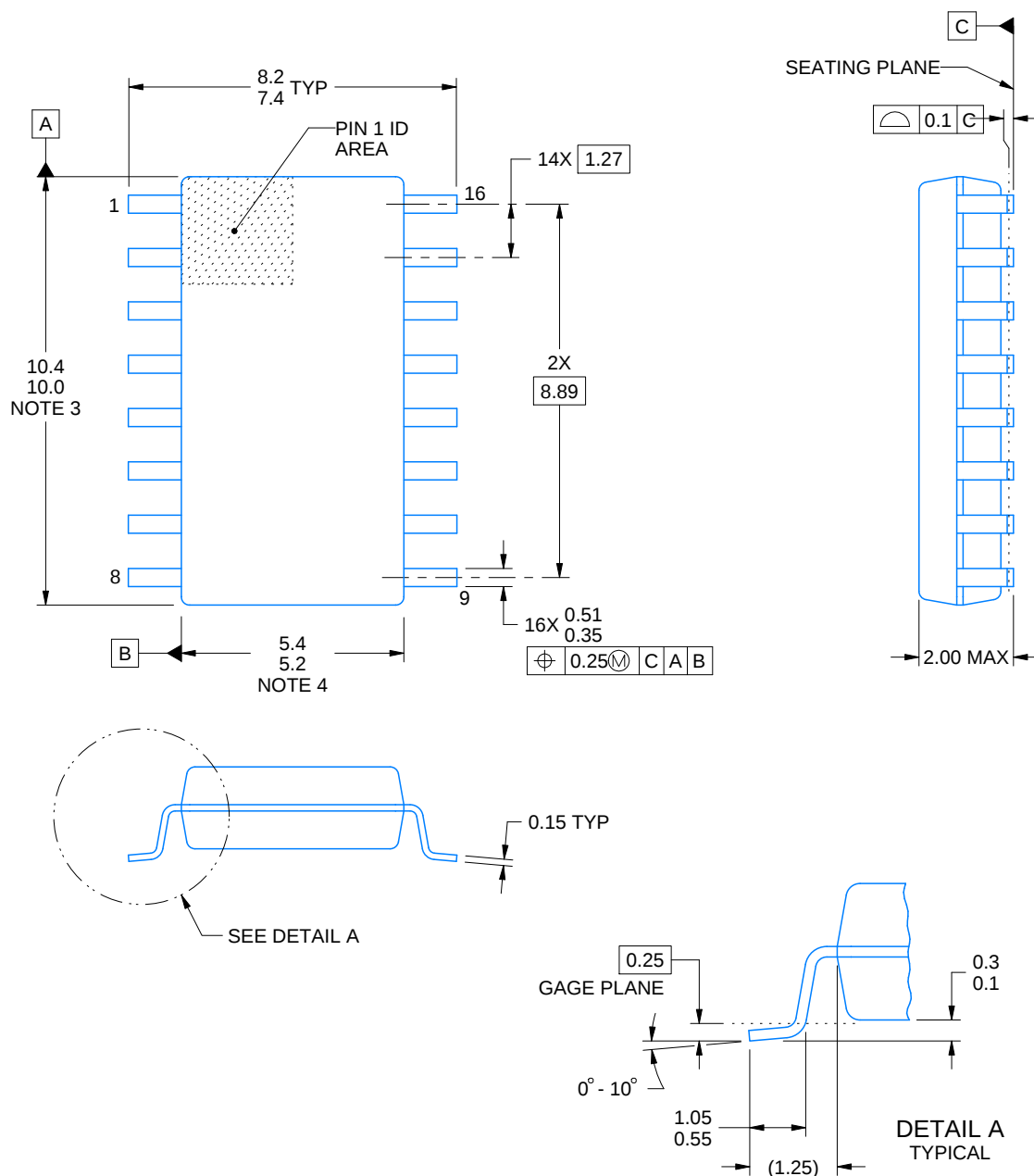


PACKAGE OUTLINE

NS0016A

SOP - 2.00 mm max height

SOP



4220735/A 12/2021

NOTES:

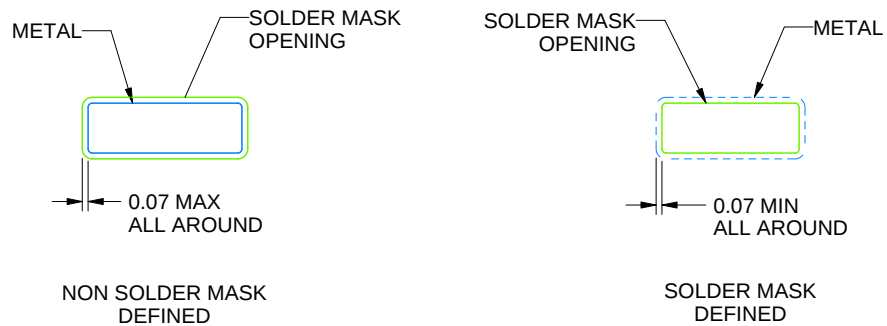
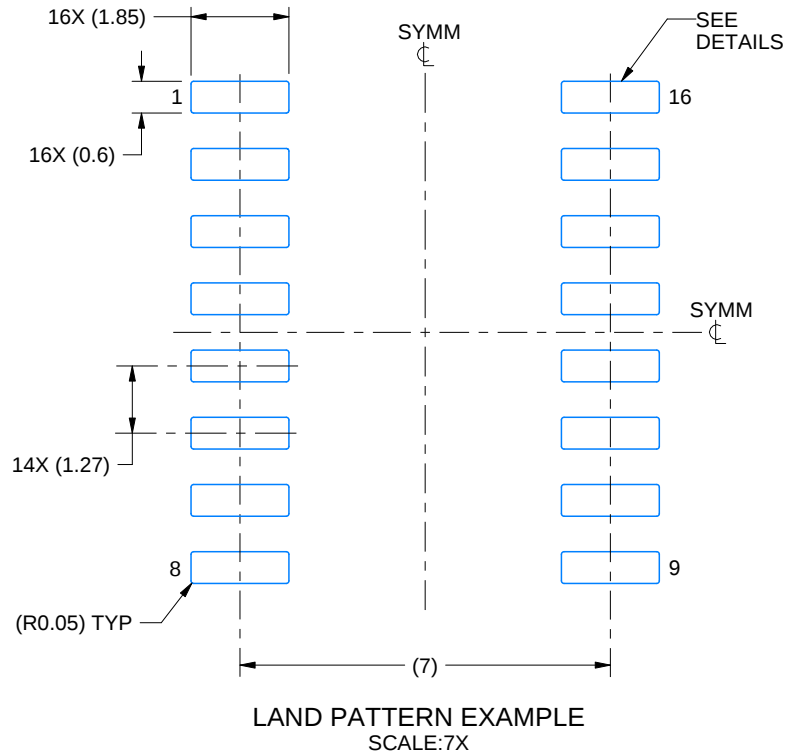
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.

EXAMPLE BOARD LAYOUT

NS0016A

SOP - 2.00 mm max height

SOP



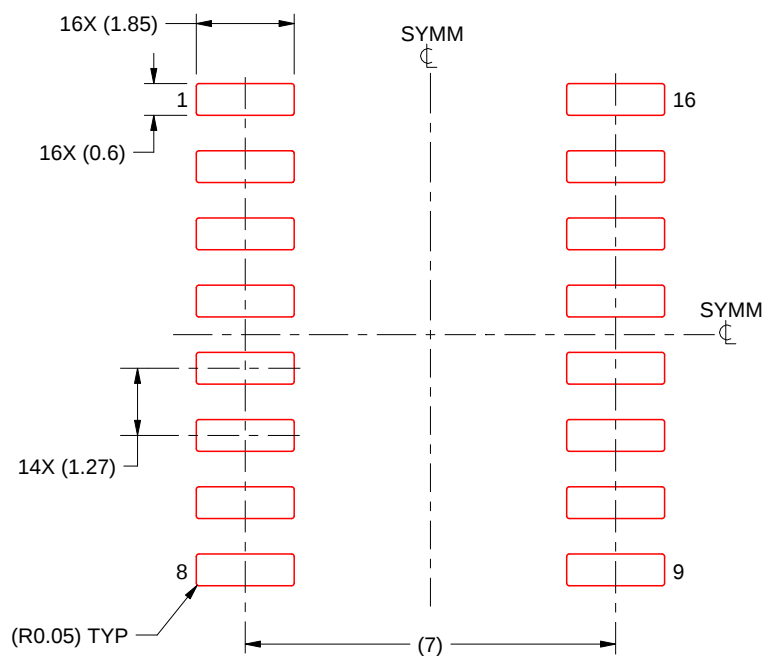
SOLDER MASK DETAILS

4220735/A 12/2021

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL
 SCALE:7X

4220735/A 12/2021

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025